

<b>Notice of References Cited</b>	Application/Control No. 10/789,097	Applicant(s)/Patent Under Reexamination TAKANO ET AL.	
	Examiner Julie Anne Watko	Art Unit 2627	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0105189 A1	06-2004	Ohtomo et al.	360/126
*	B	US-2003/0053251 A1	03-2003	Yoshida et al.	360/126
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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	K	US-			
	L	US-			
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**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

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